

<b>Notice of References Cited</b>	Application/Control No. 10/613,525	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Elizabeth E. Mulvaney	Art Unit 1774	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,033,752	03-2000	Suzuki et al.	428/64.1
*	B	US-6,982,111	01-2006	Mizushima et al.	428/64.1
*	C	US-6,996,055	02-2006	Mishima et al.	369/283
*	D	US-7,002,887	02-2006	Kakiuchi et al.	369/59.12
*	E	US-2003/0190551	10-2003	Aoshima et al.	430/270.12
*	F	US-2003/0202452	10-2003	Mishima et al.	369/112.23
*	G	US-2003/0223351	12-2003	Aoshima et al.	369/288
*	H	US-2003/0231577	12-2003	Mishima et al.	369/283
*	T	US-2004/0004932	01-2004	Inoue et al.	369/283
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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